Notice of References Cited Application/Control No. 10/800,040 Examiner Henry N. Tran Applicant(s)/Patent Under Reexamination HU ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-7,015,882	03-2006	Yumoto, Akira	345/76
*	В	US-7,042,162	05-2006	Yamazaki et al.	315/169.1
*	O	US-7,046,240	05-2006	Kimura, Hajime	345/212
*	D	US-6,914,390	07-2005	Koyama, Jun	315/169.3
*	Е	US-2006/0082524	04-2006	Kwon, Oh-Kyong	345/076
	F	US-			
	G	US-			
	Н	US-			
	ı	US-			
	j	US-			
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.